P-Channel 20 V (D-S) MOSFET

$\begin{array}{|c|c|c|c|c|c|} \hline \textbf{PRODUCT SUMMARY} \\ \hline V_{DS} (V) & R_{DS(on)} (\Omega) \mbox{Max.} & I_{D} (A) & Q_{g} (\mbox{Typ.}) \\ \hline & 0.0036 \mbox{ at } V_{GS} = -10 \mbox{ V} & -40^{e} \\ \hline & 0.0048 \mbox{ at } V_{GS} = -4.5 \mbox{ V} & -40^{e} \\ \hline & 0.0090 \mbox{ at } V_{GS} = -2.5 \mbox{ V} & -40^{e} \\ \hline \end{array}$

PowerPAK 1212-8S

3.3 mm

FEATURES

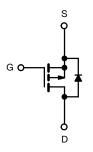
3.3 mm 0.75 mm

Bottom View

Ordering Information:Si7655ADN-T1-GE3 (Lead (Pb)-free and Halogen-free)

APPLICATIONS

- Smart Phones, Tablet PCs, Mobile Computing
 - Battery Switch
 - Load Switch



P-Channel MOSFET

Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	- 20	V	
Gate-Source Voltage		V _{GS}	± 12	v	
	T _C = 25 °C		- 40 ^e		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	I _D	- 40 ^e		
Continuous Diam Current (1) = 150 C)	T _A = 25 °C	'b	- 31 ^{a, b}		
	T _A = 70 °C		- 25 ^{a, b}		
Pulsed Drain Current (t = 300 μs)	I _{DM}	- 100	Α		
Outliness Outlines Bridge Outlines	T _C = 25 °C	ı	- 40 ^e		
Continuous Source-Drain Diode Current	T _A = 25 °C	- I _S	- 4 ^{a, b}		
Avalanche Current	L = 0.1 mH	I _{AS}	- 20		
Single-Pulse Avalanche Energy	L = 0.1 IIII1	E _{AS}	20	mJ	
	T _C = 25 °C		57		
Maximum Pawar Dissination	T _C = 70 °C	P _D	36	w	
Maximum Power Dissipation	T _A = 25 °C	טי	4.8 ^{a, b}	VV	
	T _A = 70 °C		3 ^{a, b}		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 50 to 150	°C	
Soldering Recommendations (Peak Temperature) ^{c, d}			260		

Si7655ADN

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THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{a, b}	t ≤ 10 s	R_{thJA}	21	26	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R _{thJC}	1.7	2.2	C/ VV	

Notes:

a.Surface mounted on 1" x 1" FR4 board. b.Maximum under steady state conditions is 63 °C/W

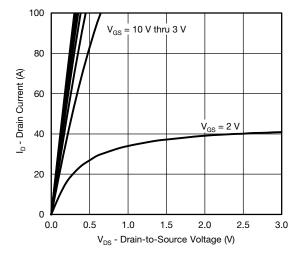
SPECIFICATIONS (T _J = 25 °C Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static	Зуппоп	rest Conditions	IVIIII.	ıyρ.	IVIAA.	Jill
Drain-Source Breakdown Voltage	V	$V_{GS} = 0 \text{ V, } I_{D} = -250 \mu\text{A}$	- 20			V
	V _{DS}	V _{GS} = 0 V, I _D = - 250 μA	- 20	- 12		
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I _D = - 250 μA		2.6		mV/ °C
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	V V I 050 ·· A	0.5	2.0	4.4	V
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	- 0.5		- 1.1	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}$			- 1	μΑ
0.01.1.0.18		$V_{DS} = -20 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			- 10	·
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -10 \text{ V}$	- 20			Α
	_	V _{GS} = - 10 V, I _D = - 20 A		0.0030	0.0036	
Drain-Source On-State Resistance ^a	$R_{DS(on)}$	V _{GS} = - 4.5 V, I _D = - 15 A		0.0039	0.0048	Ω
		V _{GS} = - 2.5 V, I _D = - 10 A		0.0062	0.0090	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 20 A		90		S
Dynamic ^b						
Input Capacitance	C _{iss}			6600		
Output Capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		890		pF
Reverse Transfer Capacitance	C_{rss}			930		
Total Gate Charge	Q _g	$V_{DS} = -10 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -20 \text{ A}$		150	225	nC
Total date offarge				72	110	
Gate-Source Charge		$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -20 \text{ A}$		12		
Gate-Drain Charge	Q _{gd}			19		
Gate Resistance	R_{g}	f = 1 MHz	0.5	2.6	5.2	Ω
Turn-On Delay Time	t _{d(on)}			45	90	
Rise Time	t _r	$V_{DD} = -10 \text{ V}, R_1 = 1 \Omega$		45	90	† - -
Turn-Off DelayTime	t _{d(off)}	$I_D \cong -10 \text{ A}, V_{GEN} = -4.5 \text{ V}, R_q = 1 \Omega$		100	200	
Fall Time	t _f			35	70	
Turn-On Delay Time	t _{d(on)}			13	25	ns
Rise Time	t _r	$V_{DD} = -10 \text{ V, R}_{1} = 1 \Omega$		10	20	1
Turn-Off DelayTime		$t_{d(off)}$ $I_D \cong -10 \text{ A}, V_{GEN} = -10 \text{ V}, R_g = 1 \Omega$		110	220	1
Fall Time	t _f	3.2.t		25	50	1
Drain-Source Body Diode Characterist	•					
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 40 ^c	
Pulse Diode Forward Current ^a	I _{SM}	10 == =			- 100	A
OW		I _F = - 10 A		- 0.75	- 1.2	V
Body Diode Reverse Recovery Time	t _{rr}	. _F 1071		30	60	ns
Body Diode Reverse Recovery Charge	Q _{rr}	1		17	26	nC
Reverse Recovery Fall Time		$I_F = -10 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		15	20	110
rieverse riecovery rail rillie	t _a	-		15		ns

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

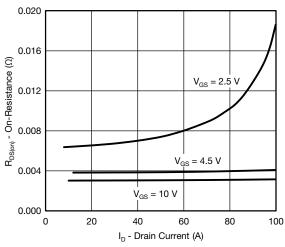
Notes: a. Pulse test; pulse width \leq 300 μ s, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing. c. Package limited.

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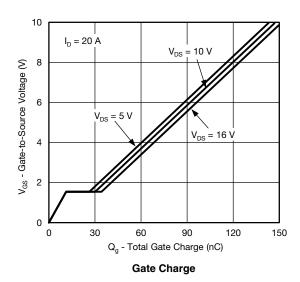
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

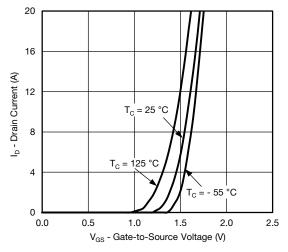


Output Characteristics

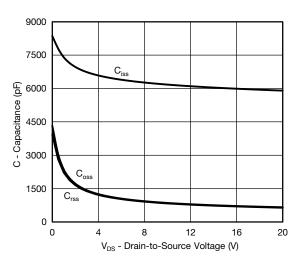


On-Resistance vs. Drain Current and Gate Voltage

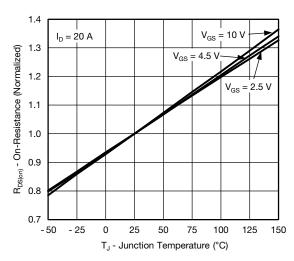




Transfer Characteristics



Capacitance

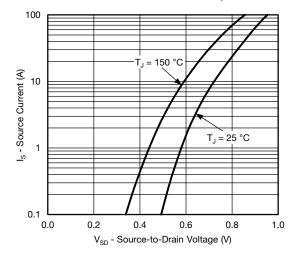


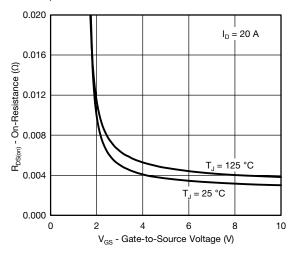
On-Resistance vs. Junction Temperature

Si7655ADN

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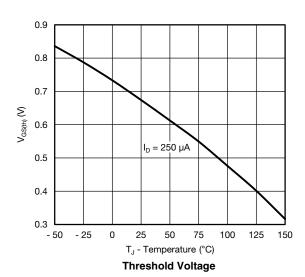
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

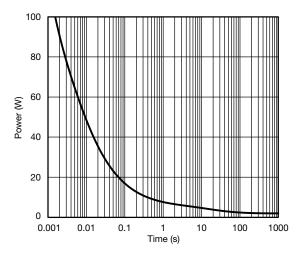




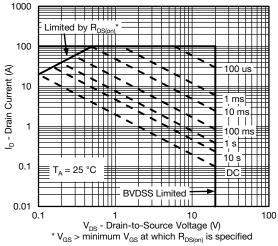
Source-Drain Diode Forward Voltage







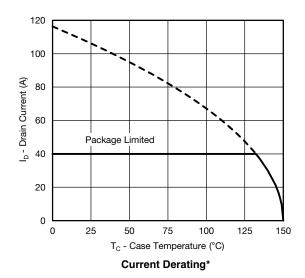
Single Pulse Power, Junction-to-Ambient

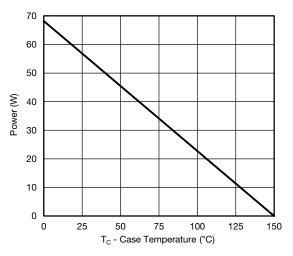


Safe Operating Area, Junction-to-Ambient

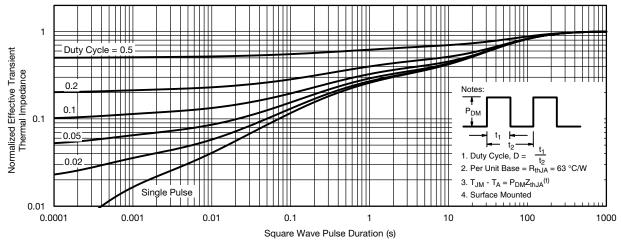
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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





Power, Junction-to-Case



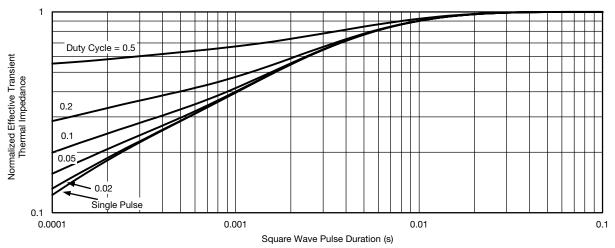
Normalized Thermal Transient Impedance, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max.)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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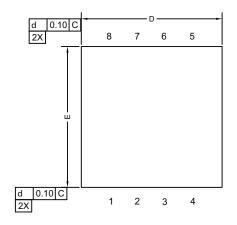
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

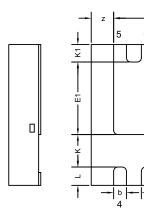


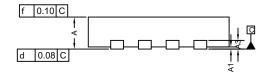
Normalized Thermal Transient Impedance, Junction-to-Case

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Case Outline for PowerPAK® 1212-8S







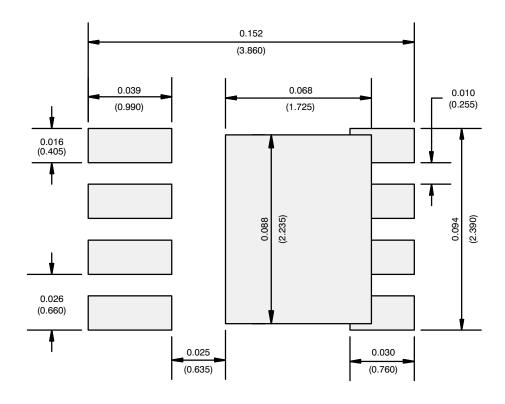
DIM.	MILLIMETERS			INCHES			
	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.	
Α	0.67	0.75	0.83	0.027	0.030	0.033	
A1	0	-	0.05	0	-	0.002	
А3	0.20 REF			0.008 REF			
b	0.30 BSC			0.012 BSC			
D	3.30 BSC			0.130 BSC			
D1	2.15	2.25	2.35	0.084	0.088	0.092	
E	3.30 BSC			0.130 BSC			
E1	1.60	1.70	1.80	0.063	0.067	0.071	
е	0.65 BSC			0.026 BSC			
K	0.76 TYP			0.030 TYP			
K1	0.41 TYP			0.016 TYP			
L	0.43 BSC			0.017 BSC			
Z	0.525 TYP			0.021 TYP			

DWG: 6008

Note

• Millimeters will govern.

RECOMMENDED MINIMUM PADS FOR PowerPAK® 1212-8 Single



Recommended Minimum Pads Dimensions in Inches/(mm)

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